



Home | Log in | Logout | Access Information | Alerts | Purchase History |
Welcome United States Patent and Trademark Office

Search Results

BROWSE

SEARCH

IEEE XPLORE GUIDE

Results for "(((chain of trust)<in>metadata) <and> ((hrl)<in>metadata))"

Your search matched 0 of 2363595 documents.

A maximum of 100 results are displayed, 25 to a page, sorted by **Relevance in Descending order**.

Join IEEE Now
Save 50%

Search Options

[View Session History](#)

[New Search](#)

Key

IEEE JNL IEEE Journal or Magazine

IET JNL IET Journal or Magazine

AIP JNL AIP Journal

AVS JNL AVS Journal

IEEE CNF IEEE Conference Proceeding

IET CNF IET Conference Proceeding

IEEE STD IEEE Standard



Indicates open access content

Modify Search

(((chain of trust)<in>metadata) <and> ((hrl)<in>metadata))

Check to search only within this results set

Display Format: Citation Citation & Abstract

IEEE/IET/AIP/AVS

Books

Educational Courses

A

IEEE/IET journals, transactions, letters, magazines, conference proceedings, AIP/standards.

No results were found.

Please edit your search criteria and try again. Refer to the Help pages if you need assistance.

Indexed by
 Inspec®

[Help](#) [Contact Us](#)

Copyright 2009